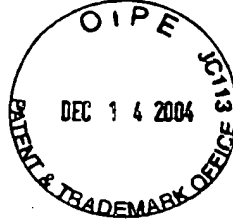


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**U.S. PATENT APPLICATION PUBLICATION**

Examiner Initial	Document Number	Date	Name	Class	Sub-class	Filing Date if Appropriate
JA	US 2002/0121132 A1	Sep. 5, 2003	Breed et al.	73	146	

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Examiner Initial	Document Number	Date	Country	Class	Sub-Class	Translation YES NO
JA	DD 2 4 4 8 1 8	15 April 1987	German Democratic Republic	G01L	1/16	X

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EXAMINER JA RW	DATE CONSIDERED: 3-28-05

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Examiner Initial	Document Number	Date	Country	Class	Sub-Class	Translation YES NO

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)

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